

Intrinsic and extrinsic semiconductors

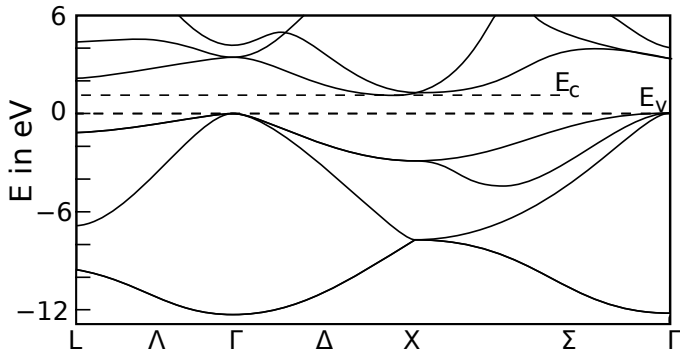
Reading:

- ▶ Kasap: 5.1 - 5.6

Band structure and conduction

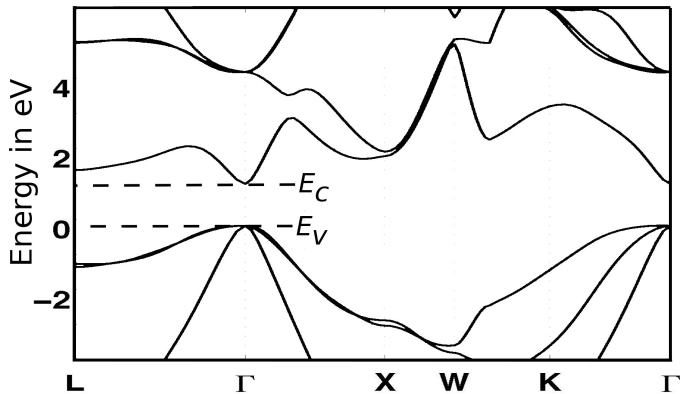
- ▶ Metals: partially filled band(s) i.e. bands cross Fermi level
- ▶ Semiconductors / insulators: each band either filled or empty ($T = 0$)
- ▶ Drude formula applicable, mobility $\mu = \frac{e\tau}{m^*}$
- ▶ Effective mass $m^* = \hbar^2 [\nabla_{\vec{k}} \nabla_{\vec{k}} E_n(\vec{k})]^{-1}$ tensorial in general
- ▶ Filled band does not conduct: $e\tau \int dk (m^*)^{-1} = 0$ for each band
- ▶ Metals conduct due to carriers near Fermi level $\sigma = g(E_F) e^2 v_F^2 \tau / 3$
- ▶ Semiconductors: $g(E_F) = 0$ (will show shortly) \Rightarrow no conduction at $T = 0$

Band structure of silicon (diamond-cubic semiconductor)



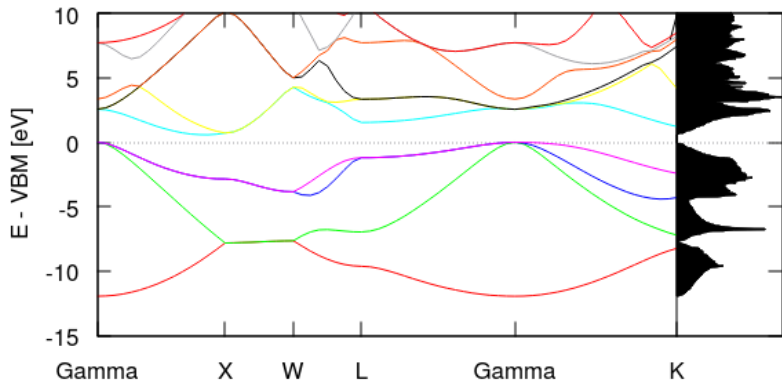
- ▶ HOMO = Valence Band Maximum (VBM) with energy E_v and LUMO = Conduction Band Minimum (CBM) with energy E_c
- ▶ HOMO-LUMO gap $E_g = E_c - E_v \approx 1.1$ eV
- ▶ HOMO and LUMO at different $\vec{k} \Rightarrow$ indirect band gap
- ▶ Diamond: similar band structure, much larger gap (≈ 5.5 eV) \Rightarrow insulator
- ▶ Valence electrons/cell = 8 (even), configuration: $3s^2 3p^2$ (two Si/cell)

Band structure of GaAs (zinc-blende semiconductor)



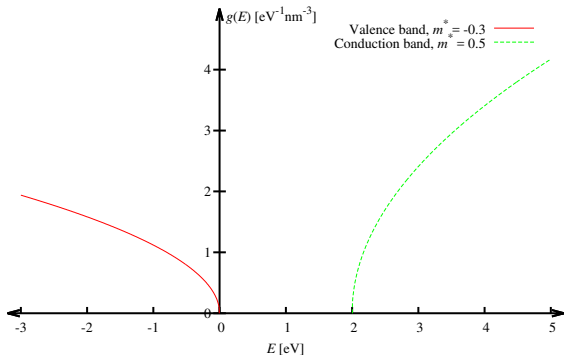
- ▶ HOMO-LUMO gap $E_g = E_c - E_v \approx 1.4$ eV
- ▶ HOMO and LUMO at same \vec{k} (Γ) \Rightarrow direct band gap
- ▶ Valence electrons/cell = 8 (even), configuration: Ga($4s^2 4p^1$), As($4s^2 4p^3$)

Density of states: silicon



- ▶ Can calculate numerically from band structure
- ▶ Parabolic band approximation valid for narrow energy range near gap

Density of states: parabolic-band semiconductor



- ▶ Parabolic bands near each band edge, with different effective masses
- ▶ Overall DOS reduces with reduced effective mass magnitude
- ▶ Set $E_v = 0$ conventionally (overall energy not well-defined)
- ▶ Conduction band edge $E_c = E_g$
- ▶ Where is the Fermi level?

Where is the Fermi level?

- ▶ At $T = 0$, valence band fully occupied $\Rightarrow f(E_v = 0) = 1 \Rightarrow E_F > 0$
- ▶ At $T = 0$, conduction band fully empty $\Rightarrow f(E_c = E_g) = 0 \Rightarrow E_F < E_g$
- ▶ Therefore, at $T = 0$, $0 < E_F < E_g$ i.e. Fermi level is in the band gap
- ▶ Chemical potential $\mu \rightarrow E_F$ as $T \rightarrow 0$
- ▶ In semiconductor physics, typically refer to $E_F(T)$ instead of $\mu(T)$
- ▶ Therefore, Fermi functions will be

$$f(E, T) = \frac{1}{\exp \frac{E - E_F(T)}{k_B T} + 1}$$

Where is the Fermi level at $T > 0$?

- ▶ Given Fermi level E_F and density of states $g(E)$
- ▶ Number of electrons in conduction band is $N_e = \int_{E_g}^{\infty} dE g(E) f(E)$
- ▶ Number of holes in valence band is $N_h = \int_{-\infty}^0 dE g(E) (1 - f(E))$
- ▶ Total number of electrons cannot change with $T \Rightarrow N_e = N_h$

$$\int_{-\infty}^0 dE g(E) (1 - f(E)) = \int_{E_g}^{\infty} dE g(E) f(E)$$

$$\int_{-\infty}^0 dE g(E) \frac{\exp \frac{E - E_F}{k_B T}}{\exp \frac{E - E_F}{k_B T} + 1} = \int_{E_g}^{\infty} dE g(E) \frac{1}{\exp \frac{E - E_F}{k_B T} + 1}$$

$$\int_{-\infty}^0 dE g(E) e^{-(E_F - E)/(k_B T)} \approx \int_{E_g}^{\infty} dE g(E) e^{-(E - E_F)/(k_B T)}$$

$$e^{-E_F/(k_B T)} \underbrace{\int_0^{\infty} d\varepsilon g(-\varepsilon) e^{-\frac{\varepsilon}{k_B T}}}_{\equiv N_v} \approx e^{(E_F - E_g)/(k_B T)} \underbrace{\int_0^{\infty} d\varepsilon g(E_g + \varepsilon) e^{-\frac{\varepsilon}{k_B T}}}_{\equiv N_c}$$

Assuming $E_F, E_g - E_F \gg k_B T$, $\varepsilon \equiv$ energy from band edge

Band edge effective density of states

- ▶ Given density of states as a function of energy away from band edge

$$N_{c/v} \equiv \int_0^{\infty} d\varepsilon g_{c/v}(\varepsilon) e^{-\frac{\varepsilon}{k_B T}}$$

- ▶ In parabolic band approximation $g(\varepsilon) = \left(\frac{\sqrt{2m^*}}{2\pi\hbar}\right)^3 4\pi\sqrt{\varepsilon}$ for both bands (but with different m^* ; for tensor m^* , above defines DOS m_{eff})
- ▶ Therefore band-edge effective of density states:

$$\begin{aligned} N_{c/v} &\equiv \int_0^{\infty} d\varepsilon \left(\frac{\sqrt{2m_{c/v}^*}}{2\pi\hbar}\right)^3 4\pi\sqrt{\varepsilon} e^{-\frac{\varepsilon}{k_B T}} \\ &= \left(\frac{\sqrt{2m_{c/v}^*}}{2\pi\hbar}\right)^3 4\pi\Gamma(3/2)(k_B T)^{3/2} = 2 \left(\frac{\sqrt{2\pi m_{c/v}^* k_B T}}{2\pi\hbar}\right)^3 \end{aligned}$$

- ▶ $N_{c/v} \propto (m_{c/v}^*)^{3/2}$ (steeper $g(\varepsilon)$ parabola)
- ▶ $N_{c/v} \propto T^{3/2}$ (climb higher up the $g(\varepsilon)$ parabola)

Fermi level for $T > 0$

- ▶ Charge neutrality imposes

$$N_v e^{-E_F/(k_B T)} = N_c e^{(E_F - E_g)/(k_B T)}$$

- ▶ Solve for Fermi level position:

$$E_F(T) = \frac{E_g}{2} + \frac{k_B T}{2} \ln \frac{N_v}{N_c}$$

- ▶ At $T \rightarrow 0$, E_F is exactly at the middle of the band gap
- ▶ At finite T , E_F moves away $\sim k_B T \ll E_g$ (still close to gap center)
- ▶ Which way does the Fermi level move with increasing T ?
- ▶ For electrons in metals (and classical gases), $\mu \downarrow$ with $T \uparrow$
- ▶ For semiconductors, $E_F(T) \downarrow$ with $T \uparrow$ iff $N_c > N_v$
(more DOS in positive m^* band; negative m^* pulls μ other way)

Electron and hole concentrations

- ▶ Number density of electrons $n \equiv N_e = N_c e^{-(E_g - E_F)/(k_B T)}$
- ▶ Number density of holes $p \equiv N_h = N_v e^{-E_F/(k_B T)}$
- ▶ Which one is larger? So far, they are equal: charge neutrality!
- ▶ Note product $np = N_c N_v e^{-E_g/(k_B T)} \equiv n_i^2$, independent of E_F
- ▶ Neutral pure semiconductor, $n = p = n_i$, intrinsic carrier density
- ▶ If $E_F \uparrow$, then $n \uparrow$ and $p \downarrow$ (more electrons than holes)
- ▶ If $E_F \downarrow$, then $n \downarrow$ and $p \uparrow$ (more holes than electrons)
- ▶ But $np = n_i^2$, constant in all these cases
- ▶ This is an equilibrium constant, eg. $[\text{H}^+][\text{OH}^-] = 10^{-14} \text{ M}^2$ in water
- ▶ How do you change E_F ? Doping! (Also later, gating)

Intrinsic semiconductor thermodynamics and transport

- ▶ Fermi level far from band edges \Rightarrow Boltzmann statistics in both bands
- ▶ Velocity distribution: Maxwell-Boltzmann distribution (classical gases)
- ▶ Internal energy of electrons $n \cdot (E_g + 3k_B T/2)$
- ▶ Internal energy of holes $-p \cdot (-3k_B T/2)$ (holes are missing electrons!)
- ▶ Net internal energy $n \cdot (E_g + 3k_B T/2) - p \cdot (-3k_B T/2)$
- ▶ Drude theory conductivity $\sigma = ne\mu_e + pe\mu_h$

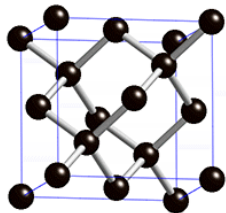
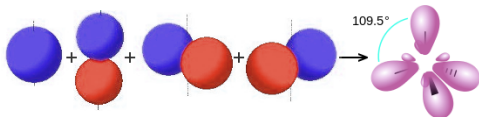
Intrinsic semiconductors: typical values at $T = 300$ K

	E_g [eV]	m_e^*/m_e	m_h^*/m_e	N_c [cm ⁻³]	N_v [cm ⁻³]	n_i [cm ⁻³]
Ge	0.66	0.04,0.28	1.64,0.08	1.0×10^{19}	6.0×10^{18}	2.3×10^{13}
Si	1.10	0.16,0.49	0.98,0.19	2.8×10^{19}	1.2×10^{19}	1.0×10^{10}
GaAs	1.42	0.082	0.067	4.7×10^{17}	7.0×10^{18}	2.1×10^6

- ▶ Note that m_{eff} for $N_{c/v}$ is an average of longitudinal / transverse values ($m_{\text{eff}} = m_L^{1/3} m_T^{2/3}$; for values see Table 5.1 in Kasap)
- ▶ N_c and N_v increase with m_{eff}
- ▶ n_i drops exponentially with increasing E_g

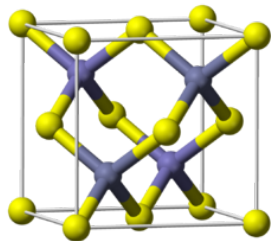
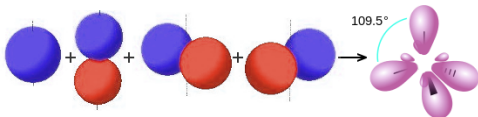
Diamond-cubic structure: sp^3 bonding

- ▶ Valence s and three p orbitals \Rightarrow four sp^3 hybrid orbitals
- ▶ Orbitals point towards vertices of regular tetrahedron
- ▶ Si, C, Ge: 4 valence electrons each
- ▶ Form covalent bonds with four neighbours (8 shared electrons/atom)
- ▶ Bonding orbitals \rightarrow valence band, anti-bonding orbitals \rightarrow conduction band
- ▶ Tetrahedral network: FCC lattice with two atoms per cell



Zinc-blende structure: sp^3 bonding

- ▶ Valence s and three p orbitals \Rightarrow four sp^3 hybrid orbitals
- ▶ Orbitals point towards vertices of regular tetrahedron
- ▶ Combine Ga,In (3 electrons) with As,Sb (5 electrons)
- ▶ Form covalent bonds with four neighbours (8 shared electrons/atom)
- ▶ Bonding orbitals \rightarrow valence band, anti-bonding orbitals \rightarrow conduction band
- ▶ Tetrahedral network: FCC lattice with two atoms per cell
- ▶ With Al and N, tend to form closely related Wurtzite structure (FCC to HCP cell)



Doping: acceptors and donors

- ▶ Extra / impurity Group III atoms: one less electron per atom
- ▶ Extra / impurity Group V atom: one extra electron per atom
- ▶ Covalent bonding theory: atoms want 8 (filled-shell) of shared electrons
- ▶ Group III 'acceptor': pick up electron from solid \Rightarrow hole in valence band
- ▶ Group V 'donor': give electron to solid \Rightarrow electron in conduction band

Simple picture of doping:

- ▶ Density N_a of acceptor atoms: charge $-eN_a$
- ▶ Density N_d of donor atoms: charge $+eN_d$
- ▶ Charge neutrality $-en + ep - eN_a + eN_d = 0 \Rightarrow n - p = N_d - N_a$
- ▶ Change in n and p due to shift in E_F , but $np = n_i^2$
- ▶ Solve for n and p , then find $E_F = \frac{E_g}{2} + \frac{k_B T}{2} \ln \frac{n N_v}{p N_c} = E_{F0} + \frac{k_B T}{2} \ln \frac{n}{p}$
- ▶ Even simpler picture: usually $N_d, N_a \gg n_i \Rightarrow$ either $p \gg n$ or $n \gg p$

Doping: *p*-type and *n*-type

n-type semiconductor:

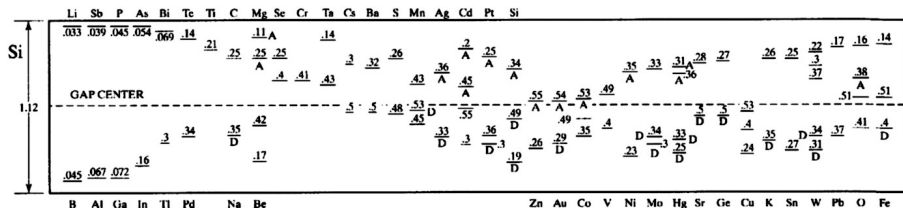
- ▶ Donor impurities dominate $N_d > 0$ ($N_a = 0$ or $< N_d$)
- ▶ Typically $N_d - N_a \gg n_i \Rightarrow n \gg p$ (since $p = n_i^2/n$)
- ▶ Therefore $n \approx N_d - N_a, p \approx n_i^2/(N_d - N_a)$
- ▶ $E_F = E_{F0} + \frac{k_B T}{2} \ln \frac{n}{p} = E_{F0} + k_B T \ln \frac{N_d - N_a}{n_i}$ (shifted \uparrow towards CBM)
- ▶ Current predominantly carried by electrons

p-type semiconductor:

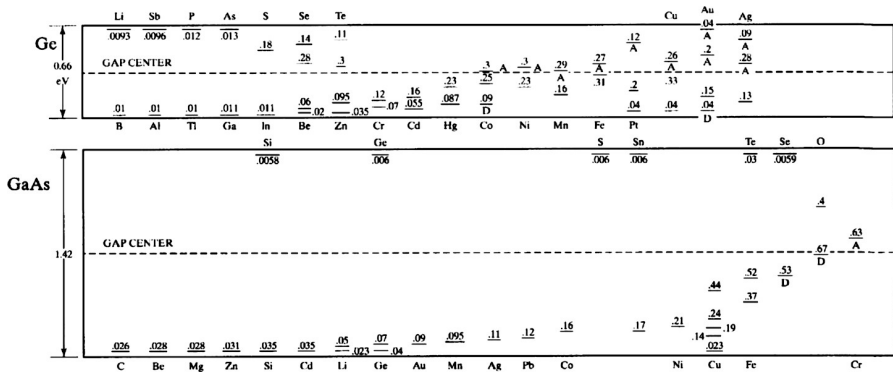
- ▶ Acceptor impurities dominate $N_a > 0$ ($N_d = 0$ or $< N_a$)
- ▶ Typically $N_a - N_d \gg n_i \Rightarrow p \gg n$ (since $n = n_i^2/p$)
- ▶ Therefore $p \approx N_a - N_d, n \approx n_i^2/(N_a - N_d)$
- ▶ $E_F = E_{F0} + \frac{k_B T}{2} \ln \frac{n}{p} = E_{F0} - k_B T \ln \frac{N_a - N_d}{n_i}$ (shifted \downarrow towards VBM)
- ▶ Current predominantly carried by holes

Doping: a more complete picture

- ▶ Simple picture: donor atom donates an electron, becomes positively charged
- ▶ Positively charged donor ion can bind electrons: like a hydrogen atom
- ▶ Binding energy of pseudo-hydrogenic atom $E_b = \epsilon_r^{-2} \frac{m^*}{m_e} \text{Ryd} \sim 0.05 \text{ eV}$
- ▶ Donor level: $E_d = E_c - E_b$ (electrons bound relative to CBM)
- ▶ Exact argument for acceptors and holes, with charges swapped
- ▶ Acceptor level: $E_a = E_v + E_b$ (holes bound relative to VBM)
- ▶ Levels in Si: note some impurities introduce multiple levels



Dopant levels in Ge and GaAs



- ▶ For GaAs, Group II or Group VI are shallow dopants
- ▶ For GaAs, Group IV can be donor and acceptor dopants: how?

Donor charge density

- ▶ For each donor atom, degenerate donor levels typically with $g_d = 2$ (spin)
- ▶ Electron occupation: zero or one for the whole atom (repulsions)
- ▶ Probability of occupation zero $\propto 1$
- ▶ Probability of occupation one $\propto g_d \exp \frac{E_F - E_d}{k_B T}$
- ▶ Normalized probability of ionized donor (occupation zero):

$$P_d^+ = \frac{1}{1 + g_d \exp \frac{E_F - E_d}{k_B T}}$$

- ▶ Therefore number density of ionized donors:

$$N_d^+ = \frac{N_d}{1 + g_d \exp \frac{E_F - E_d}{k_B T}}$$

(which is $\approx N_d$ as long as E_F several $k_B T$ below E_d)

Acceptor charge density

- ▶ For each acceptor atom, degenerate acceptor levels typically with $g_a = 4$ (two for spin, two for degenerate hole bands)
- ▶ Hole occupation: zero or one for the whole atom (repulsions)
- ▶ Probability of hole occupation zero $\propto 1$
- ▶ Probability of hole occupation one $\propto g_a \exp \frac{E_a - E_F}{k_B T}$
(tricky: flip energy axis when thinking in terms of holes)
- ▶ Normalized probability of ionized donor (hole occupation zero):

$$P_a^- = \frac{1}{1 + g_a \exp \frac{E_a - E_F}{k_B T}}$$

- ▶ Therefore number density of ionized acceptors:

$$N_a^- = \frac{N_a}{1 + g_a \exp \frac{E_a - E_F}{k_B T}}$$

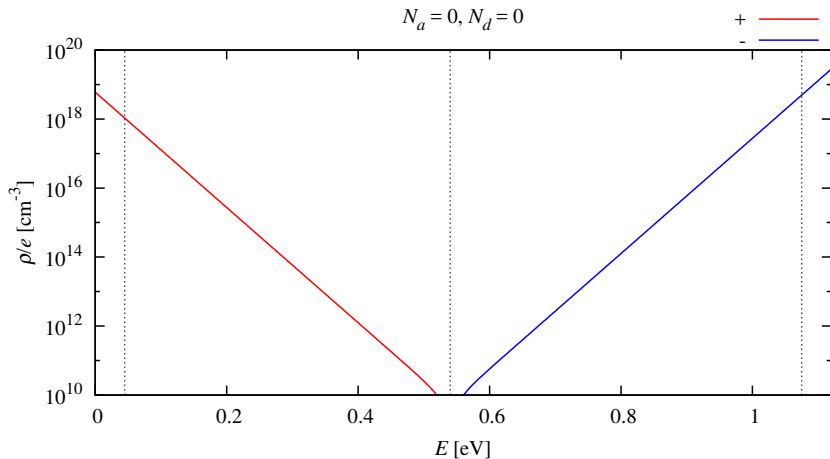
(which is $\approx N_a$ as long as E_F several $k_B T$ above E_a)

Charge neutrality

$$\begin{aligned}
 0 &= \rho(E_F) \\
 &= -en + ep + eN_d^+ - eN_a^- \\
 &= e \left[\underbrace{-N_c e^{-\frac{E_g - E_F}{k_B T}}}_n + \underbrace{N_v e^{-\frac{E_F}{k_B T}}}_p + \frac{N_d}{1 + g_d e^{\frac{E_F - E_d}{k_B T}}} - \frac{N_a}{1 + g_a e^{\frac{E_a - E_F}{k_B T}}} \right]
 \end{aligned}$$

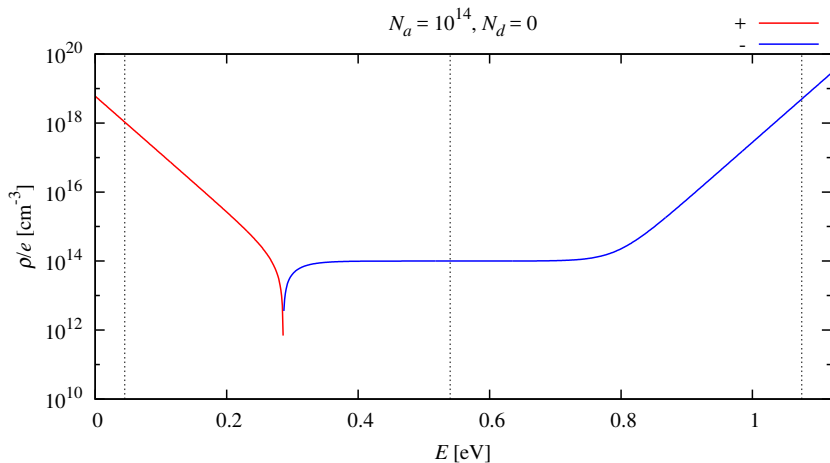
- ▶ If $N_a - N_d \gg n_i$, then $p \gg n$ (p -type)
- ▶ If $N_d - N_a \gg n_i$, then $n \gg p$ (n -type)
- ▶ Previous simple analysis holds if:
 - ▶ Net doping is stronger than n_i (one of the two regimes above), and
 - ▶ Doping is small enough that E_F is far above E_a and far below E_d (remember E_F moves up/down $\sim k_B T \ln \frac{N_{d/a}}{n_i}$)

$\rho(E_F)$: intrinsic semiconductor



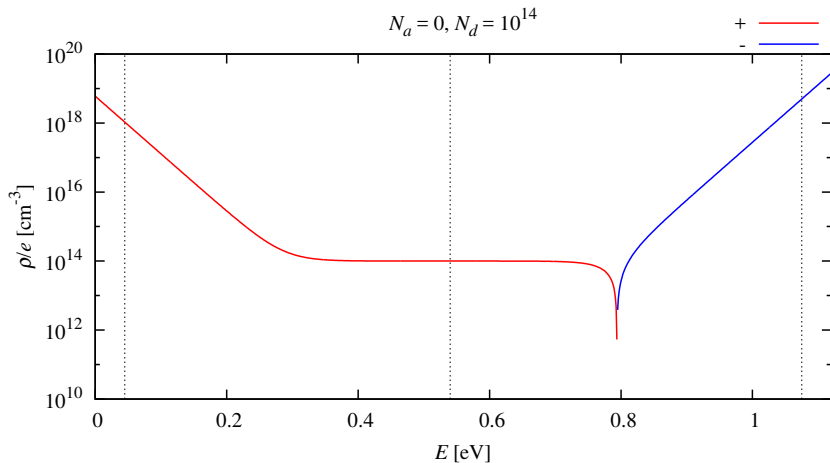
- ▶ Electrons increase with increasing E_F (hence ρ decreases)
- ▶ Cross-over point from + to - is neutral E_F

$\rho(E_F)$: moderate p doping



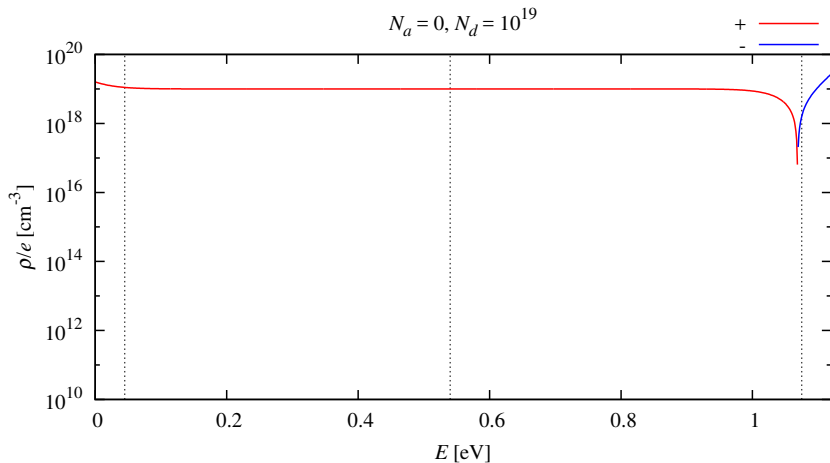
- ▶ Acceptors pull down Fermi level
- ▶ At moderate doping level, far from mid-gap and acceptor levels

$\rho(E_F)$: moderate n doping



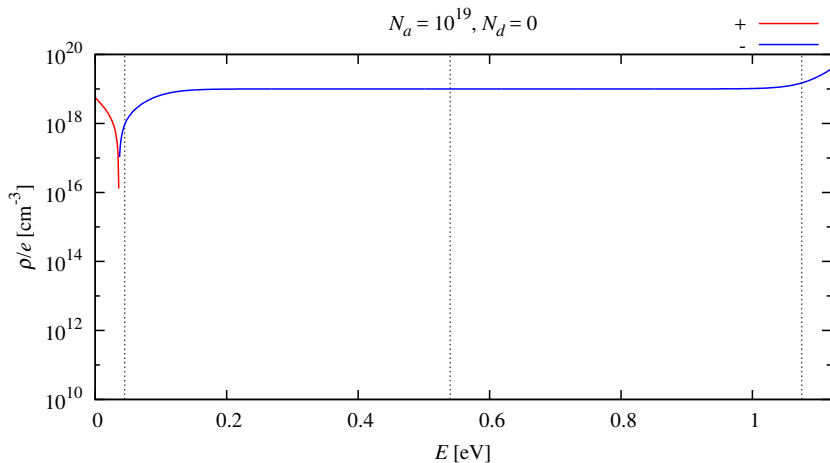
- ▶ Donors pull up Fermi level
- ▶ At moderate doping level, far from mid-gap and donor levels

$\rho(E_F)$: high n doping



- ▶ At high n doping level, approach / cross donor level
- ▶ Donors may be partially ionized (simple model no longer works)

$\rho(E_F)$: high p doping



- ▶ At high p doping level, approach / cross acceptor level
- ▶ Acceptors may be partially ionized (simple model no longer works)

Degenerate doping

- ▶ High-enough n doping: Fermi level enters conduction band (' $n+$ ')
 - ▶ High-enough p doping: Fermi level enters valence band (' $p+$ ')
 - ▶ One of our approximations breaks down for $n+$ case with $E_F > E_g$, $n \not\approx N_c e^{-(E_g - E_F)/(k_B T)}$ but instead

$$n \approx \frac{1}{3\pi^2} \left(\frac{\sqrt{2m^*(E_F - E_g)}}{\hbar} \right)^3$$

- ▶ Similarly, for $p+$ case with $E_F < 0$:

$$p \approx \frac{1}{3\pi^2} \left(\frac{\sqrt{2m^*(-E_F)}}{\hbar} \right)^3$$

- ▶ These are the Fermi theory expressions with $k_F = \sqrt{2m^*\varepsilon_F}/\hbar$ (where ε_F is Fermi energy relative to band edge)!
- ▶ Important: partial donor / acceptor ionization in this regime

Partial donor ionization

- ▶ Consider a p -type material ($N_d = 0$) with $E_F = E_a$
(we cross this point as we increase p -doping before getting to $p+$)
- ▶ Around this E_F , acceptors are partially ionized
- ▶ When exactly does this occur?
- ▶ Since E_F far from conduction band, neglect $n \ll p$
- ▶ Charge neutrality yields

$$N_v e^{-\frac{E_F}{k_B T}} = \frac{N_a}{1 + g_a \exp \frac{E_a - E_F}{k_B T}}$$

$$\Rightarrow N_v e^{-\frac{E_a}{k_B T}} = \frac{N_a}{1 + g_a}$$

$$\Rightarrow k_B T = \frac{E_a}{\log \frac{(1+g_a)N_v}{N_a}}$$

- ▶ Therefore, this happens for high N_a when $E_a \ll k_B T$
- ▶ But also, for $k_B T$ lower than E_a : dopant freeze-out
- ▶ Importance of shallow donor/acceptor levels!
(for donors, replace $E_a \rightarrow E_g - E_d$)

Carrier density in ionization regime

- ▶ If T much smaller than ionization threshold, neutrality:

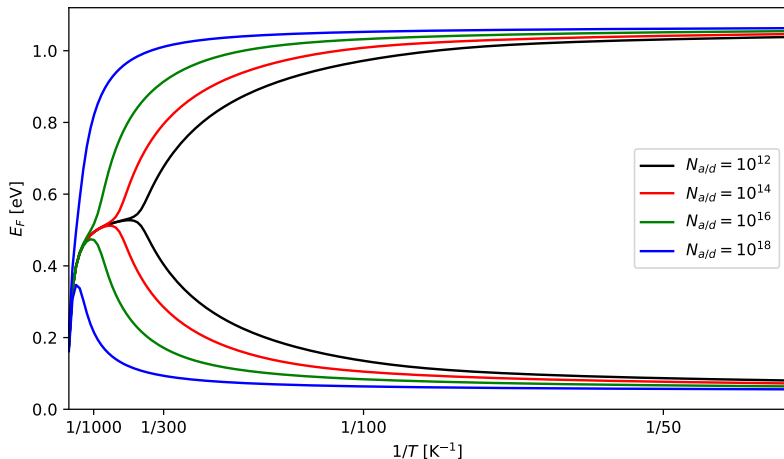
$$N_v e^{-\frac{E_F}{k_B T}} = \frac{N_a}{1 + g_a \exp \frac{E_a - E_F}{k_B T}}$$

$$\rightarrow N_v e^{-\frac{E_F}{k_B T}} \approx \frac{N_a}{g_a} e^{-\frac{E_a - E_F}{k_B T}}$$

$$\Rightarrow E_F = \frac{E_a}{2} + \frac{k_B T}{2} \log \frac{g_a N_v}{N_a}$$

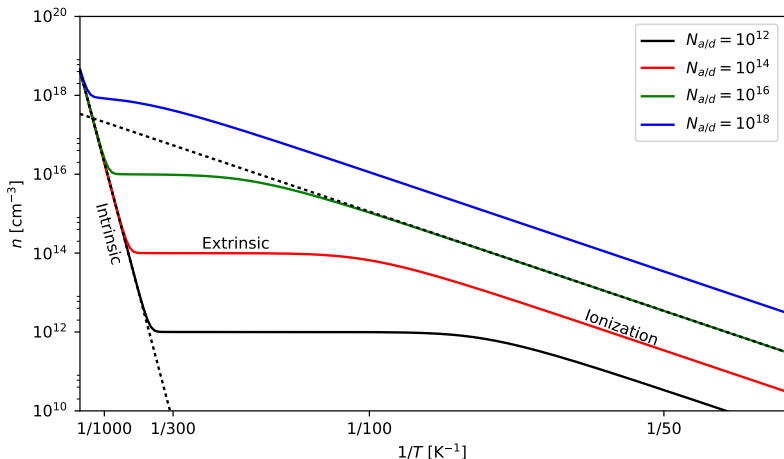
- ▶ Very similar to intrinsic case, except N_a/g_a replaces N_c
- ▶ Effective gap between valence band and acceptor level!
- ▶ In this regime, $p^2 = p \cdot N_a^- = (N_v N_a / g_a) \exp \frac{-E_a}{k_B T}$
- ▶ Similar behavior for frozen-out donors in ionization regime for n -type

Temperature dependence of E_F



- ▶ Doping dominates at low T , approach intrinsic level at high T
- ▶ At low T , Fermi level decided by donor/acceptor level
- ▶ Note using $E_{a/d} = 0.1$ eV from band edges to exaggerate effect

Temperature dependence of carrier concentration



- ▶ Ionization regime at low T upto threshold which increases with $N_{d/a}$
- ▶ Constant concentration in extrinsic regime; threshold increases with $N_{d/a}$
- ▶ At high T , dopants don't matter: intrinsic regime

Intrinsic mobility

- ▶ Drude theory: mobility $\mu = e\tau/m^*$
- ▶ Typically semiconductor $m^* \sim 0.1 - 1 m_e$, so expect higher μ than metals
- ▶ At room temperature, $\mu_{i-Si}^e \sim 1400 \text{ cm}^2/(\text{Vs})$ and $\mu_{Ag} \sim 60 \text{ cm}^2/(\text{Vs})$
- ▶ Effective mass alone does not explain it!
- ▶ Remember $\tau_{e-ph}^{-1} \propto g(E)T$
- ▶ For metals, $g(E) \rightarrow g(E_F)$ since most carriers near Fermi level
- ▶ For semiconductors, carriers within few $k_B T$ of band edge where $g(E) \propto \sqrt{E}$ (and much smaller than metals)
- ▶ Averaged over carriers, $\overline{g(E)} \propto \sqrt{T}$
- ▶ Therefore, $\tau_{e-ph}^{-1} \propto T^{3/2}$ and $\mu \propto \tau \propto T^{-3/2}$

Impurity scattering

- ▶ Doped semiconductor contains ionized donors / acceptors
- ▶ Charged impurities cause electron PE $\propto 1/r$ near them
- ▶ Electrons with KE \gg PE not scattered significantly
- ▶ Electrons with KE \ll PE scattered most strongly
- ▶ Effective cross-section $\propto r_c^2$, where $PE(r_c) \sim KE \sim k_B T$
- ▶ Therefore $r_c \propto T^{-1}$ and cross-section $\sigma_{cs} \propto T^{-2}$
- ▶ Scattering time $\tau_I = (N_{a/d} \sigma_{cs} v)^{-1}$
- ▶ Average velocity $v \propto \sqrt{T}$
- ▶ Therefore $\tau_I \propto N_{a/d}^{-1} T^{3/2}$

Extrinsic mobility

- ▶ Intrinsic scattering $\tau_{e-ph}^{-1} \propto T^{-3/2}$
- ▶ Dopant / impurity scattering $\tau_I \propto N_{a/d}^{-1} T^{3/2}$
- ▶ Net scattering $\tau \propto (T^{3/2} + N_{a/d} T^{-3/2})^{-1}$ (Mathiessen rule)
- ▶ Therefore mobility $\mu \propto (T^{3/2} + N_{a/d} T^{-3/2})^{-1}$
- ▶ At high T , e-ph scattering dominates (intrinsic regime)
- ▶ At high doping concentration (or low T), impurity scattering dominates

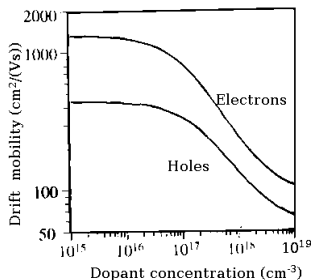
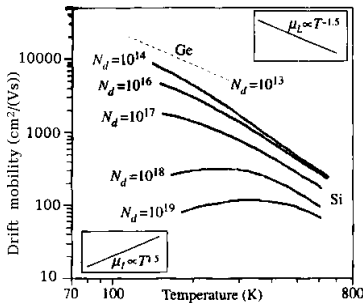


Fig. 5.18 and 5.19 from Kasap

Extrinsic conductivity

- ▶ Conductivity $\sigma = ne\mu_e + pe\mu_h$: similar dependence as n (exponentials dominate over polynomial)
- ▶ μ effect visible mainly in extrinsic regime where n is constant

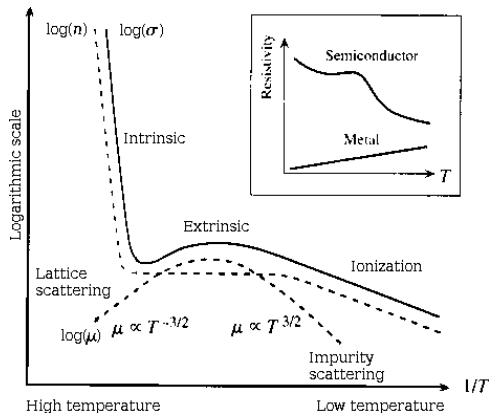
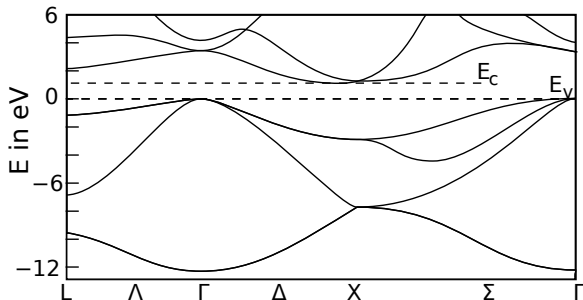


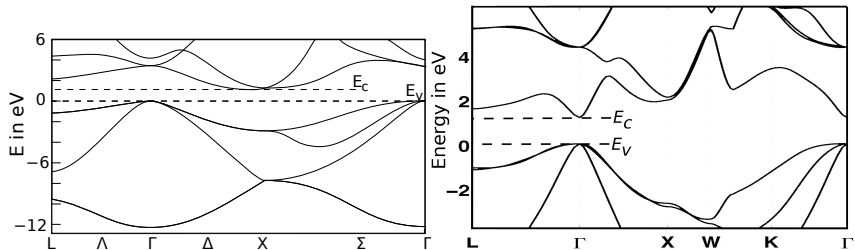
Fig. 5.20 from Kasap

Recombination



- ▶ Excite electrons and holes in semiconductor to higher energy
- ▶ e-ph scattering brings electrons and holes to band edges
- ▶ If $np > n_i^2$, equilibrium: nothing further happens
- ▶ What if you make more electron-hole pairs (eg. using light) such that $np \neq n_i^2$?
- ▶ Electrons and holes will recombine to restore equilibrium

Recombination: direct vs indirect



- ▶ Direct gap: electrons and holes at band edges at same k
- ▶ Indirect gap: band edge carriers at different k
- ▶ Which will recombine faster?
- ▶ Direct gap: momentum conservation, recombine and emit light (usually)
- ▶ Indirect gap: cannot directly recombine: momentum not conserved

Recombination mechanisms

- ▶ Recombination rate proportional to $np - n_i^2$
- ▶ Radiative / direct recombination (direct gap materials)
- ▶ Trap-assisted (Shockley-Read-Hall recombination)
 - ▶ Trap level in gap captures electron (hole), becoming $- (+)$ charged
 - ▶ Later captures hole (electron), becoming neutral
 - ▶ Energy from recombination emitted to phonons
 - ▶ Probability of each capture \propto Boltzmann factor of trap depth from band edge
 - ▶ Net rate $\sim \text{sech}^2 \frac{E_t - E_g/2}{2k_B T}$ (trap level E_t)
 - ▶ Strongest for mid-band-gap states!
- ▶ Auger recombination
 - ▶ Energy and momentum of e-h pair go to excite another e or h
 - ▶ Need e or h to excite, so rate $\propto n, p$
 - ▶ Dominates at very high carrier concentrations
- ▶ Recombination rate = $\alpha(np - n_i^2)$
- ▶ Minority carrier lifetime = $1/(\max(n, p)\alpha)$